T2G6001528-Q3

18W, 28V, DC – 6 GHz, GaN RF Power Transistor

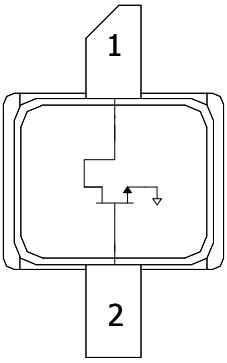
Applications

- Military radar
- Civilian radar
- Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers

Product Features

- Frequency: DC to 6 GHz
- Output Power (P_{3dB}): 19 W at 5.2 GHz
- Linear Gain: >9 dB at 5.2 GHz
- Operating Voltage: 28 V
- Low thermal resistance package

Functional Block Diagram



General Description

The TriQuint T2G6001528-Q3 is an 18W (P_{3dB}) discrete GaN on SiC HEMT which operates from DC to 6.0 GHz. The device is constructed with TriQuint's proven TQGaN25 process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

Pin Configuration

Pin No.	Label
1	V_D / RF OUT
2	V_G / RF IN
Flange	Source

Ordering Information

Part	ECCN	Description
T2G6001528-Q3	EAR99	Packaged part Flangeless
T2G6001528-Q3-EVB1	EAR99	5.0 – 6.0 GHz Evaluation Board
T2G6001528-Q3-EVB2	EAR99	1.8 – 2.6 GHz Evaluation Board

Absolute Maximum Ratings

Parameter	Value
Breakdown Voltage (BV_{DG})	100 V min.
Gate Voltage Range (V_G)	-7 to 0 V
Drain Current (I_D)	5 A
Gate Current (I_G)	-5 to 14 mA
Power Dissipation (P_D)	28 W
RF Input Power, CW, T = 25℃ (P_{IN})	36 dBm
Channel Temperature (T_{CH})	275 ℃
Mounting Temperature (30 seconds)	320 ℃
Storage Temperature	-40 to 150 ℃

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions(1)

Parameter	Value
Drain Voltage (V_D)	32 V (Typ.)
Drain Quiescent Current (I_{DQ})	50 mA (Typ.)
Peak Drain Current (I_D)	1.4 A (Typ.)
Gate Voltage (V_G)	-2.9 V (Typ.)
Channel Temperature (T_{CH})	225 ℃ (Max)
Power Dissipation, CW (P_D)[2]	20.9 W (Max)
Power Dissipation, Pulse (P_D)[3]	22.5 W (Max)

[1] Electrical specifications are measured at specified test conditions.
Specifications are not guaranteed over all recommended operating conditions.
[2] Package at 85 ℃
[3] 100uS Pulse Width, 20 % Duty Cycle, package at 85 ℃

RF Characterization – Load Pull Performance at 3.0 GHz

Test conditions unless otherwise noted: T_A = 25 ℃, V_D = 28 V, I_{DQ} = 50 mA, Pulse: 100uS, 20%

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		16.5		dB
P_{3dB}	Output Power at 3 dB Gain Compression		19.6		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		69.6		%
PAE_{3dB}	Power-Added Efficiency at 3 dB Gain		66.4		%
G_{3dB}	Gain at 3 dB Compression		13.5		dB

RF Characterization – Load Pull Performance at 6.0 GHz

Test conditions unless otherwise noted: T_A = 25 ℃, V_D = 28 V, I_{DQ} = 50 mA, Pulse: 100uS, 20%

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		11.3		dB
P_{3dB}	Output Power at 3 dB Gain Compression		19.0		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		66.0		%
PAE_{3dB}	Power-Added Efficiency at 3 dB Gain		56.2		%
G_{3dB}	Gain at 3 dB Compression		8.3		dB

RF Characterization – Performance at 5.2 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA, Pulse: 100uS, 20%

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		10.5		dB
P_{3dB}	Output Power at 3 dB Gain Compression		17.3		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		48.0		%
G_{3dB}	Gain at 3 dB Compression		7.5		dB

Notes:
1. Performance at 5.2 GHz in the 5.0 to 6.0 GHz Evaluation Board

RF Characterization – Mismatch Ruggedness at 3.50 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA

Symbol	Parameter	Typical
VSWR	Impedance Mismatch Ruggedness	10:1

Notes:
1. V_{DS} = 28 V, I_{DQ} = 50 mA, CW at P_{1dB}

Thermal and Reliability Information – Pulsed

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 5%, Tbase = 85 ℃	4.6	℃/W
Channel Temperature (T_{CH})		188	℃
Median Lifetime (T_M)		4.9 E7	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 10%, Tbase = 85 ℃	4.7	℃/W
Channel Temperature (T_{CH})		191	℃
Median Lifetime (T_M)		3.6 E7	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 20%, Tbase = 85 ℃	5.0	℃/W
Channel Temperature (T_{CH})		198	℃
Median Lifetime (T_M)		1.9 E7	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 50%, Tbase = 85 ℃	5.6	℃/W
Channel Temperature (T_{CH})		212	℃
Median Lifetime (T_M)		5.5 E6	Hrs

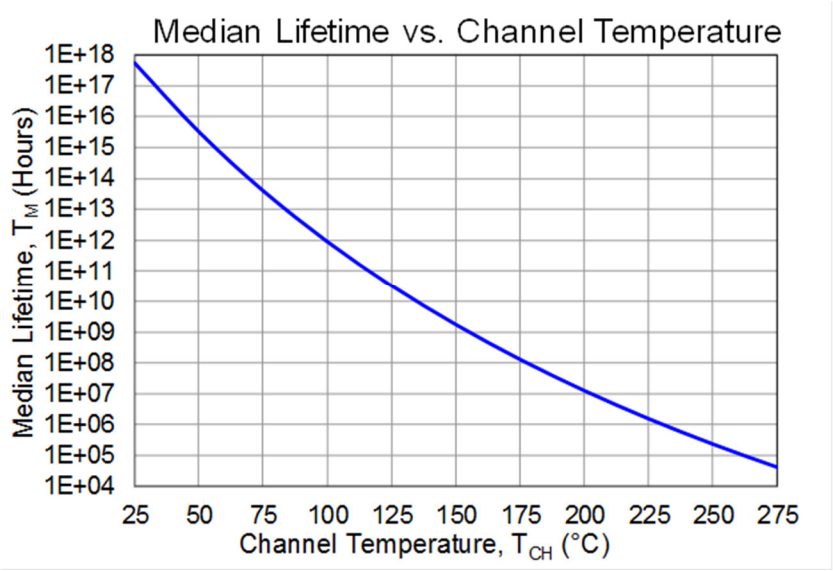
Notes:
Thermal resistance measured to bottom of package, Pulsed.

Thermal and Reliability Information – CW

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC})	Pdiss = 15W, Tbase = 85 ℃	6.2	℃/W
Channel Temperature (T_{CH})		178	℃
Median Lifetime (T_M)		1.3 E8	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 17.5W, Tbase = 85 ℃	6.5	℃/W
Channel Temperature (T_{CH})		198	℃
Median Lifetime (T_M)		1.9 E7	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 20W, Tbase = 85 ℃	6.7	℃/W
Channel Temperature (T_{CH})		219	℃
Median Lifetime (T_M)		3.0 E6	Hrs
Thermal Resistance (θ_{JC})	Pdiss = 22.5W, Tbase = 85 ℃	7.0	℃/W
Channel Temperature (T_{CH})		243	℃
Median Lifetime (T_M)		4.4 E5	Hrs

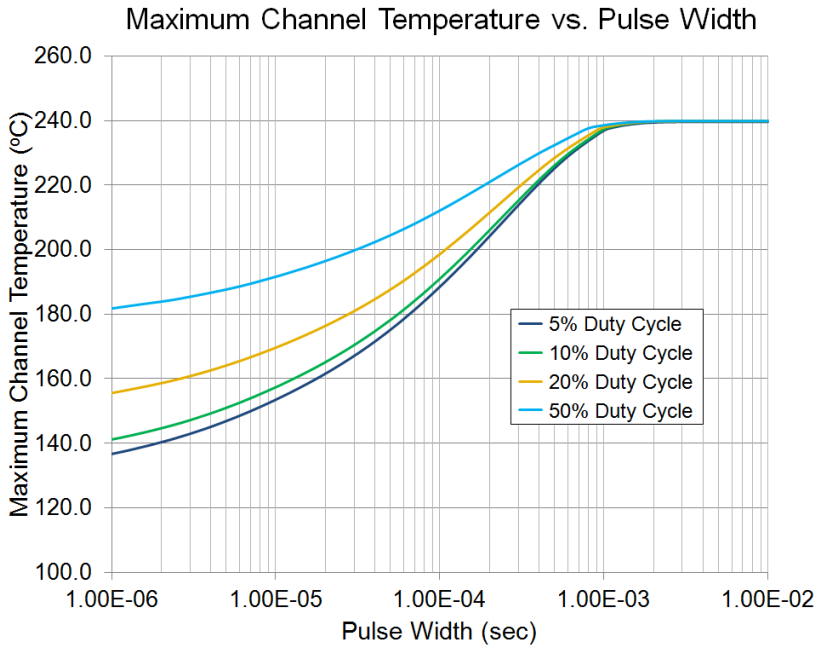
Notes:
Thermal resistance measured to bottom of package, CW.

Median Lifetime



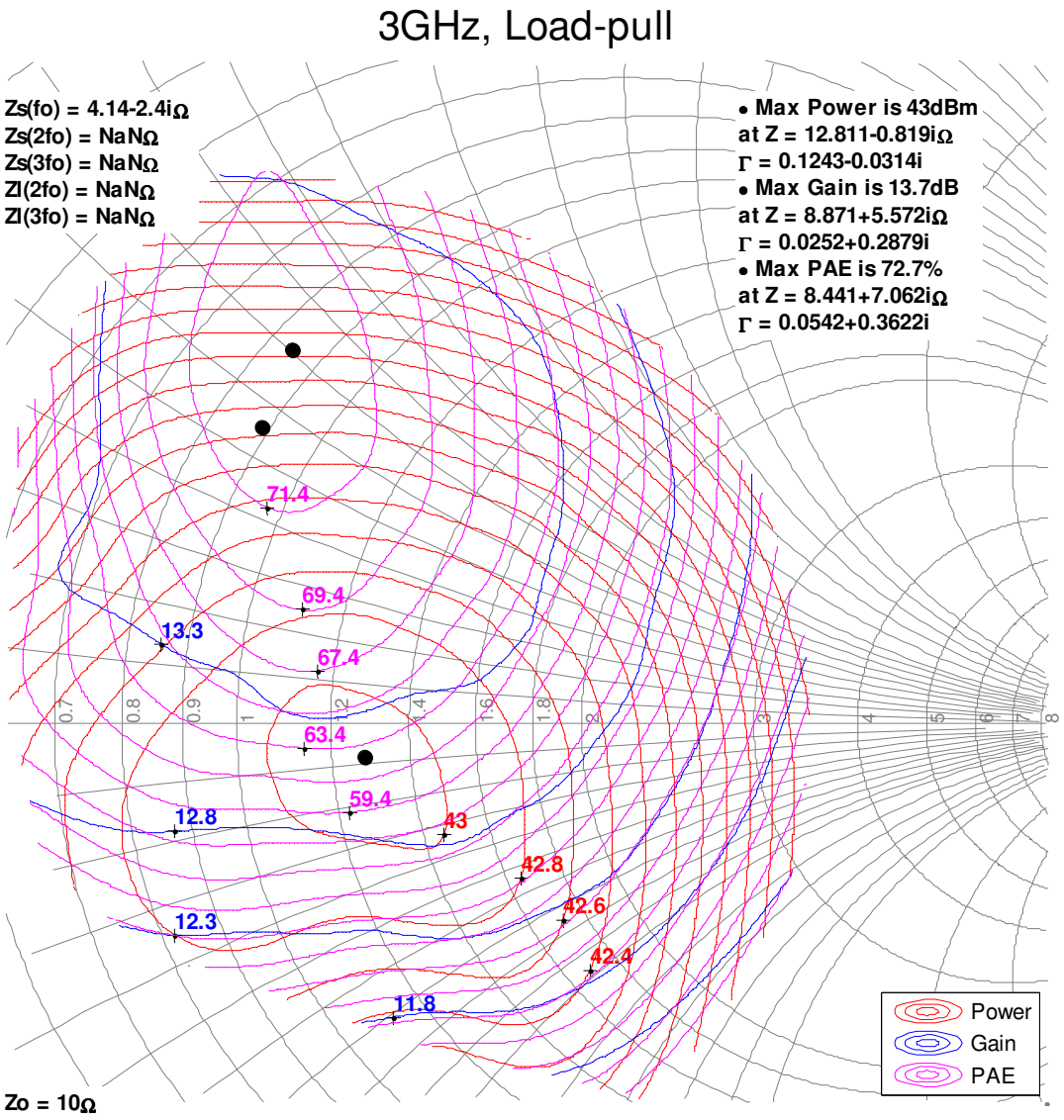
Maximum Channel Temperature

T_{BASE} = 85°C, P_D = 22.5 W



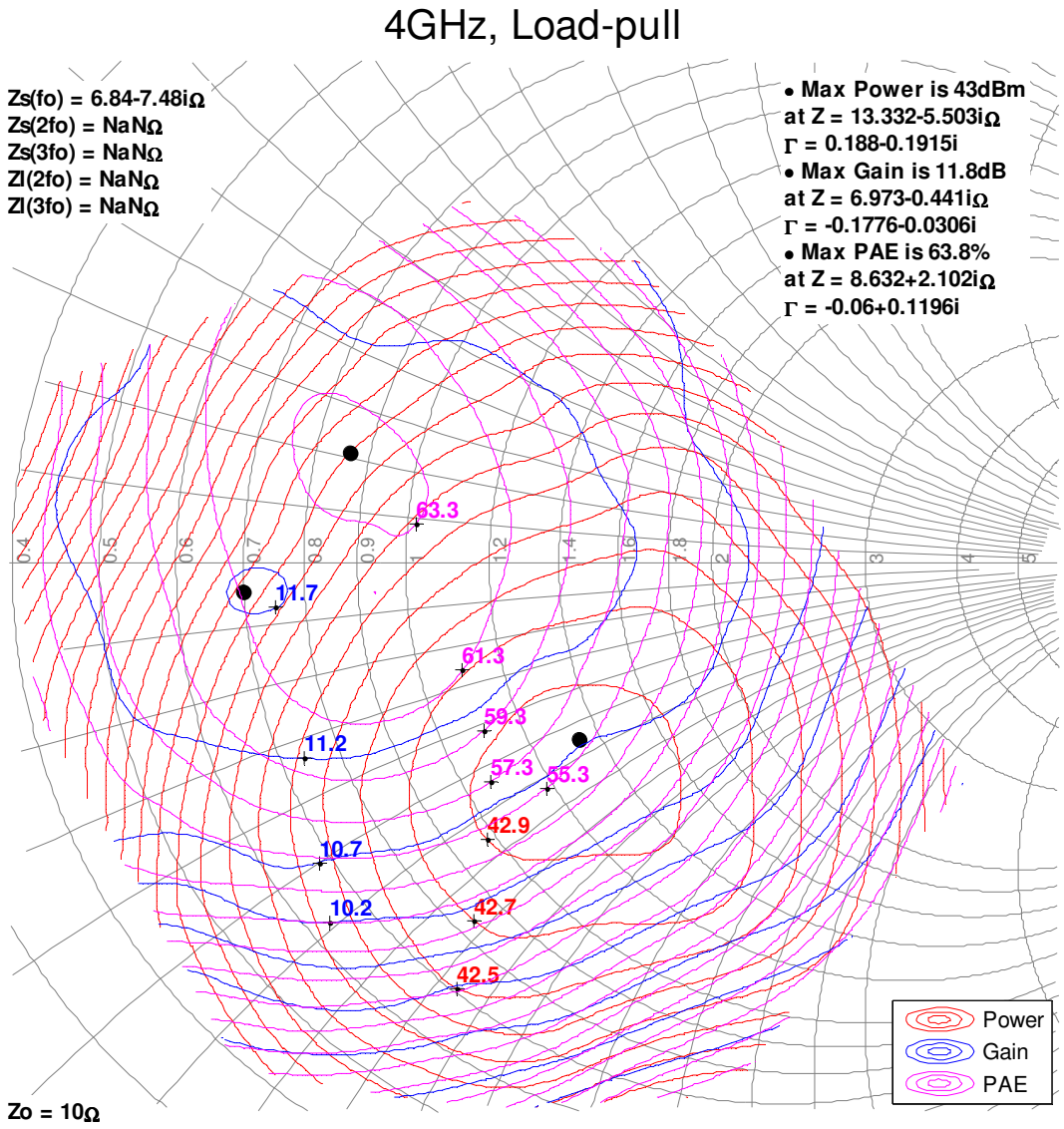
Load Pull Smith Charts (1, 2)

Notes:
1. The impedances shown are those presented to the device at load pull reference planes. See page 14.
2. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
3. Test Signal: Pulse Width = 100 µsec, Duty Cycle = 20%
4. NaN indicates the value was not set during load pull.
5. Zo is characteristic impedance of load pull fixtures.



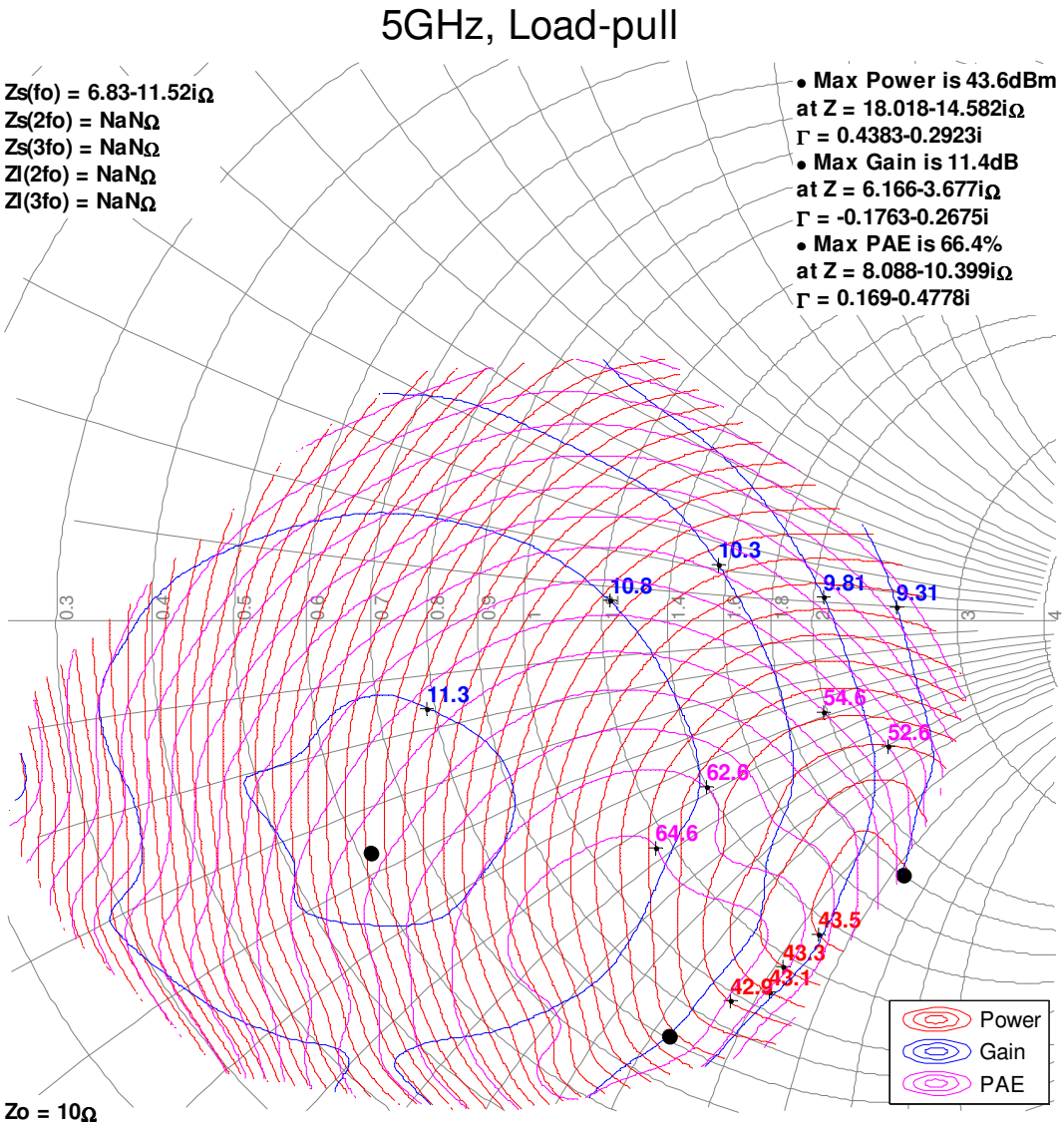
Load Pull Smith Charts (1, 2)

Notes:
1. The impedances shown are those presented to the device at load pull reference planes. See page 14.
2. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
3. Test Signal: Pulse Width = 100 µsec, Duty Cycle = 20%
4. NaN indicates the value was not set during load pull.
5. Zo is characteristic impedance of load pull fixtures.



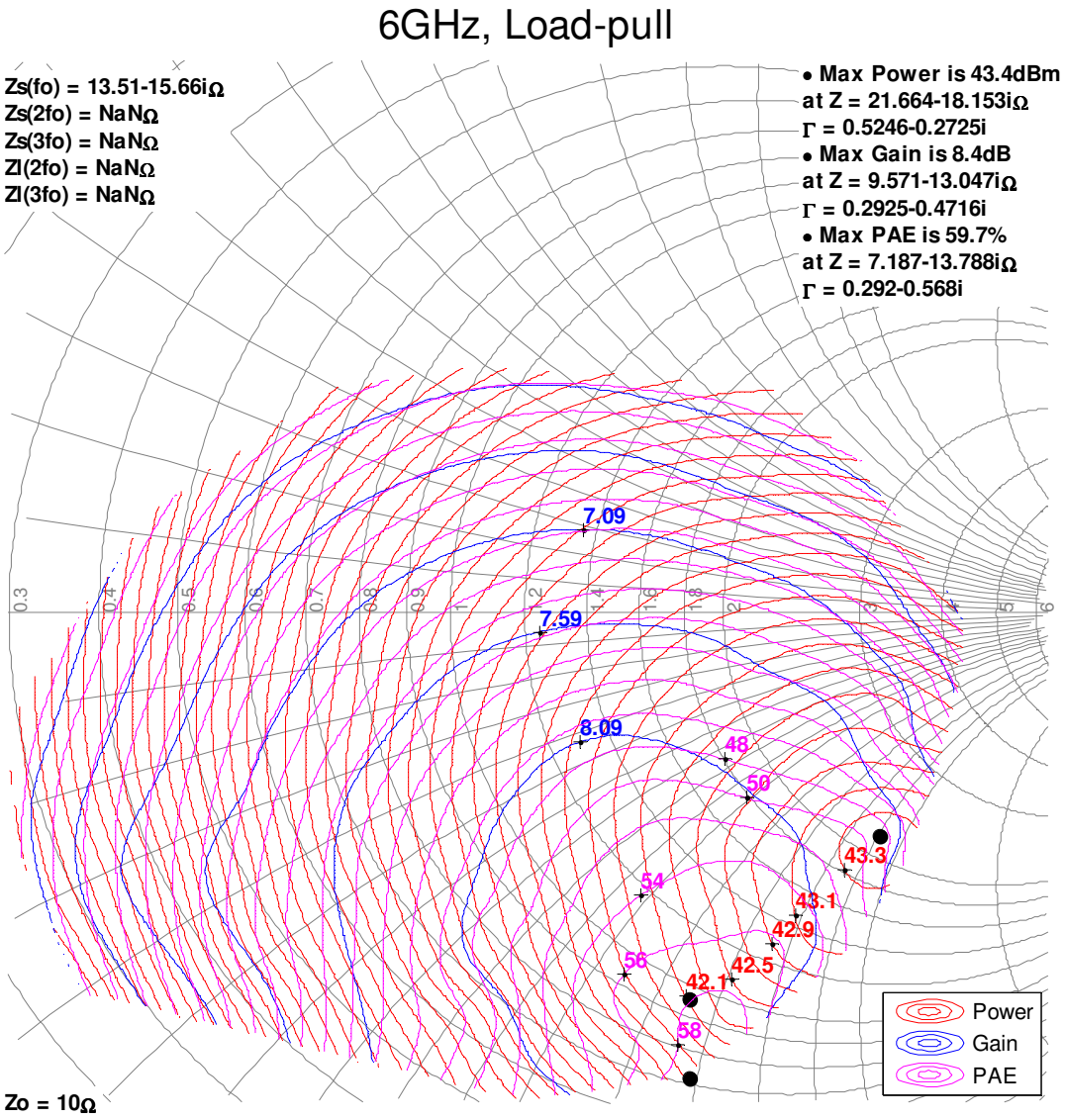
Load Pull Smith Charts (1, 2)

Notes:
1. The impedances shown are those presented to the device at load pull reference planes. See page 14.
2. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
3. Test Signal: Pulse Width = 100 µsec, Duty Cycle = 20%
4. NaN indicates the value was not set during load pull.
5. Zo is characteristic impedance of load pull fixtures.



Load Pull Smith Charts (1, 2)

Notes:
1. The impedances shown are those presented to the device at load pull reference planes. See page 14.
2. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
3. Test Signal: Pulse Width = 100 µsec, Duty Cycle = 20%
4. NaN indicates the value was not set during load pull.
5. Zo is characteristic impedance of load pull fixtures.

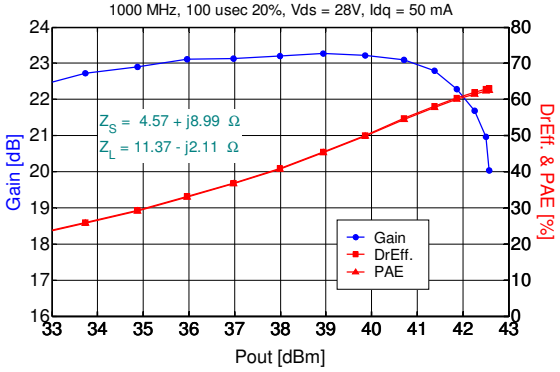


Typical Performance

Performance is based on compromised impedance point and measured at DUT reference planes. See page 14.

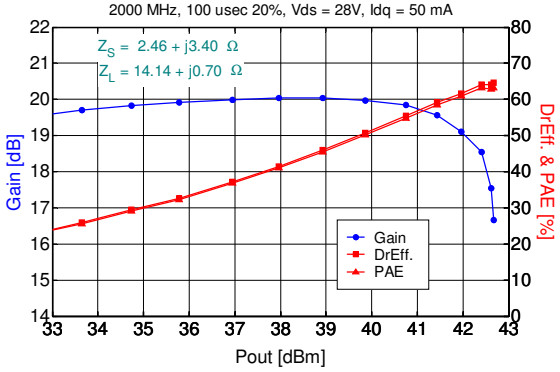
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

1000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA



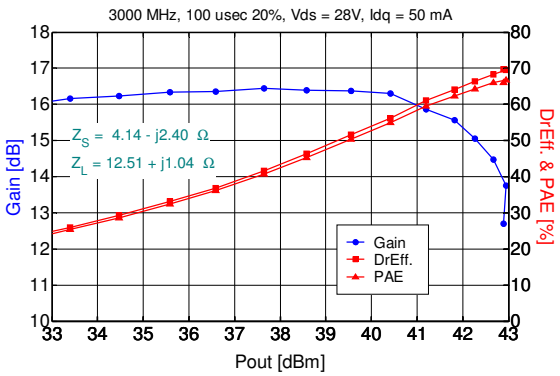
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

2000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA



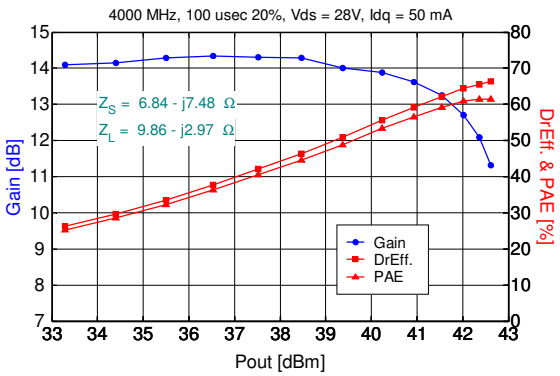
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

3000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA



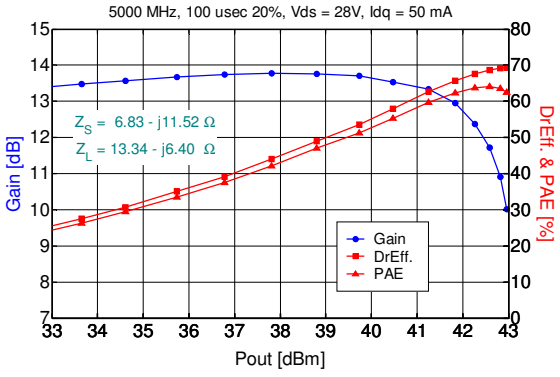
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

4000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA



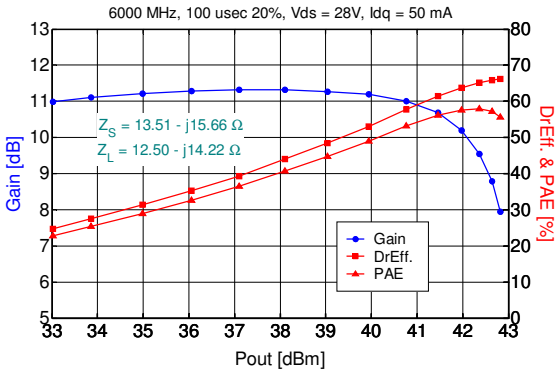
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

5000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA



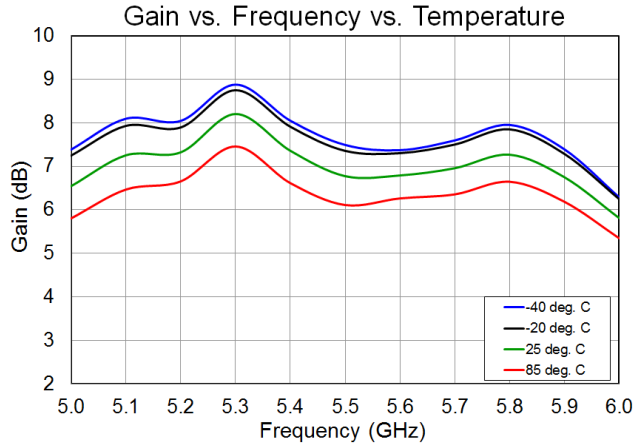
T2G6001528-Q3 Gain DrEff. and PAE vs. Pout

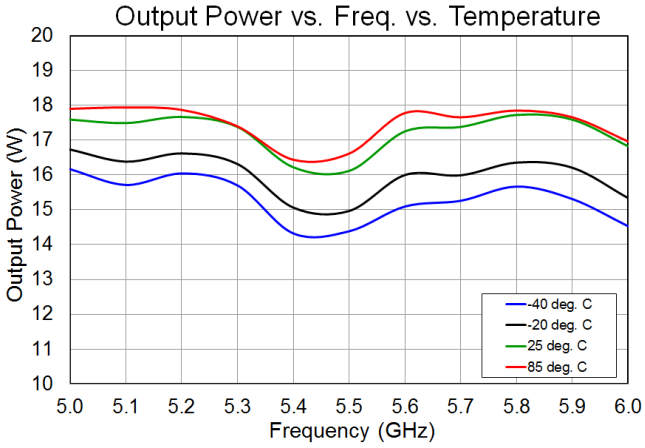
6000 MHz, 100 usec 20%, Vds = 28V, Idq = 50 mA

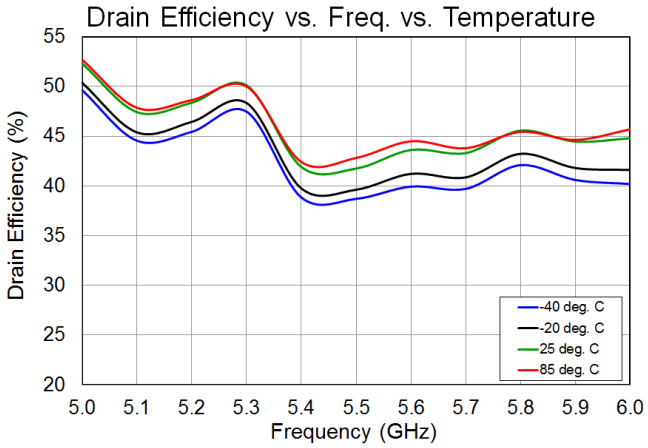


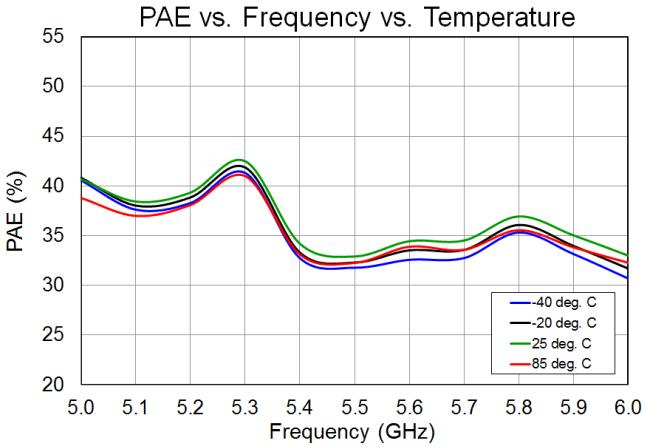
Performance Over Temperature (1, 2)

Performance measured in TriQuint's 5.0 GHz to 6.0 GHz Evaluation Board at 3 dB compression.







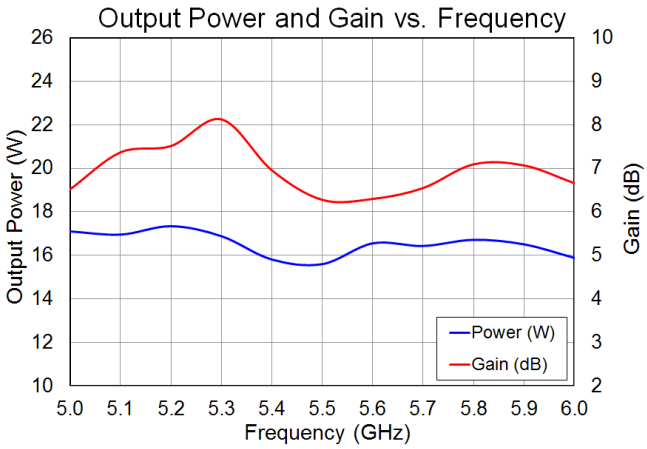


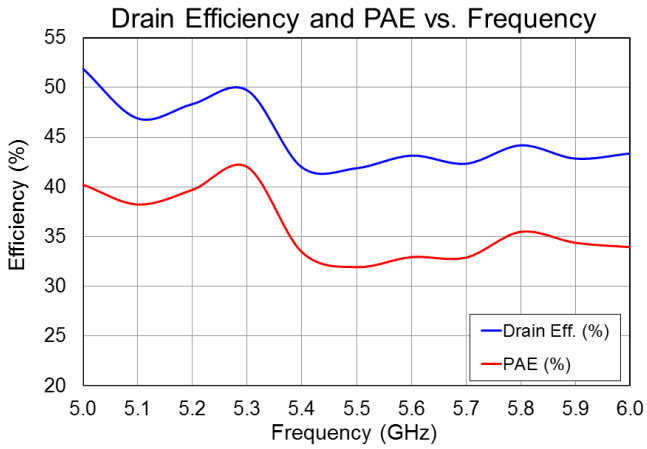
Notes:

1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
2. Test Signal: Pulse Width = 100 µs, Duty Cycle = 20%

Evaluation Board Performance (1, 2)

Performance at 3 dB Compression

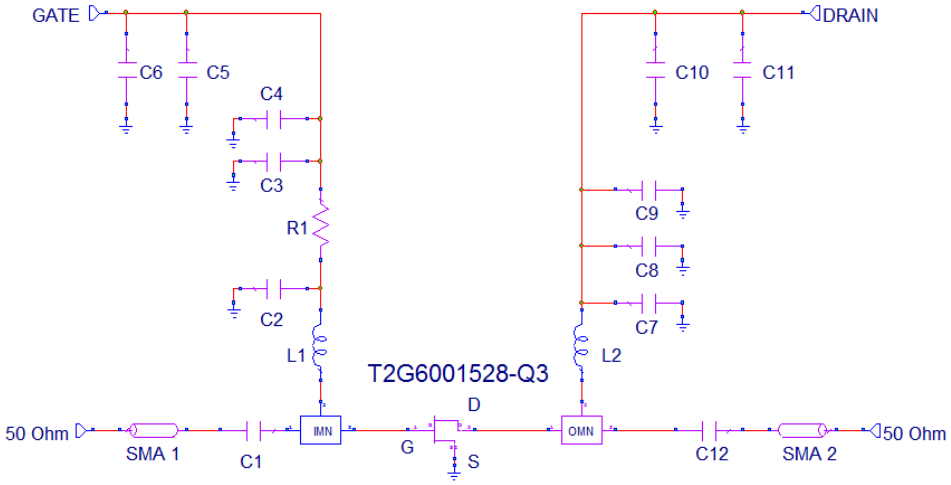




Notes:

1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
2. Test Signal: Pulse Width = 100 µs, Duty Cycle = 20 %

Application Circuit



Bias-up Procedure

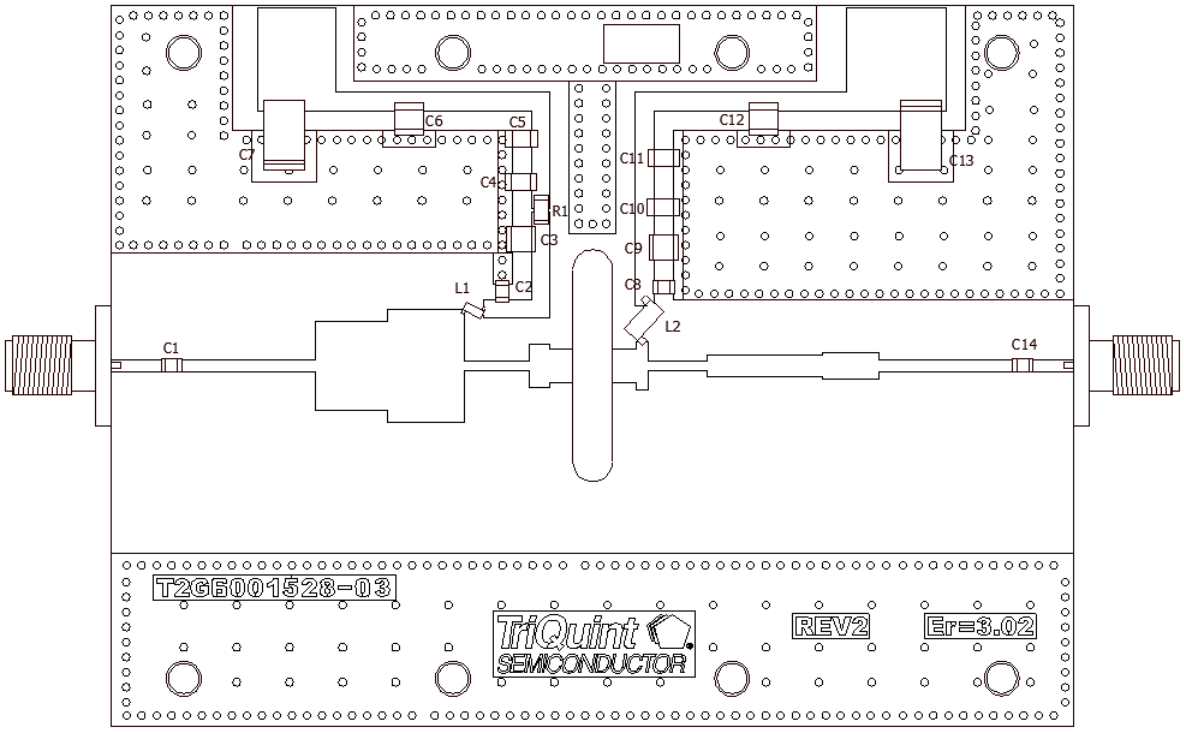
Set gate voltage (V_G) to -5.0V
Set drain voltage (V_D) to 28 V
Slowly increase V_G until quiescent I_D is 50 mA.
Apply RF signal

Bias-down Procedure

Turn off RF signal
Turn off V_D and wait 1 second to allow drain capacitor dissipation
Turn off V_G

Evaluation Board Layout

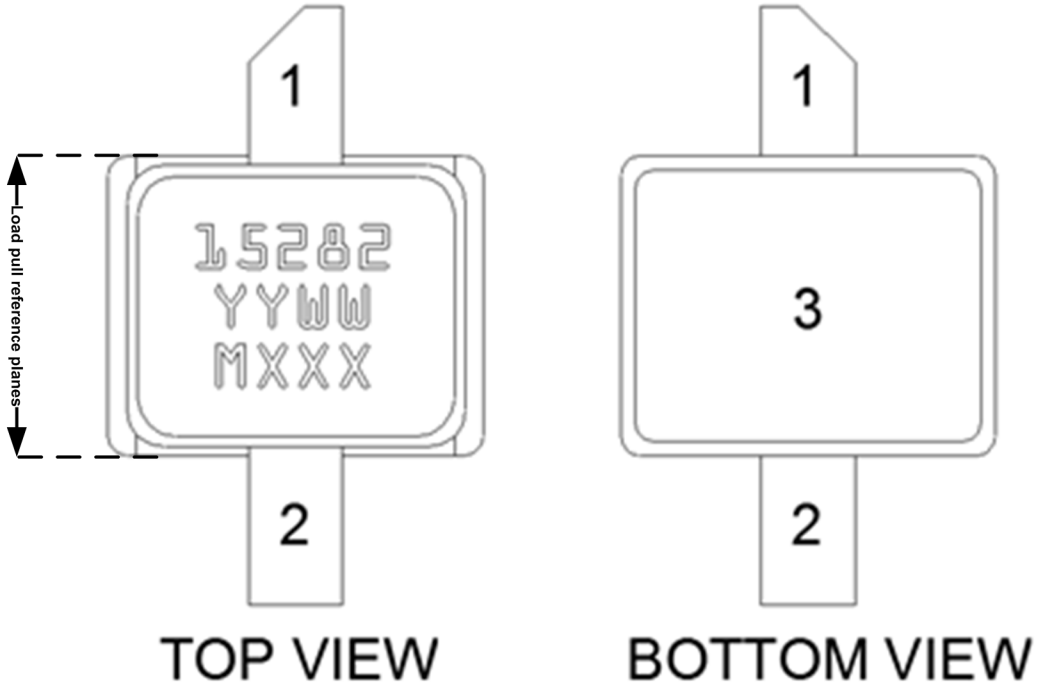
Top RF layer is 0.020" thick Rogers RO3203, ε_r = 3.02. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



Bill of Materials

Reference Design	Value	Qty	Manufacturer	Part Number
C1, C14	100 pF	2	ATC	100A101JW500XC
C2, C8	2400 pF	1	Dielectric Labs	C08BL242X-5UN-XOB
C3, C9	100 pF	2	ATC	100B101GT500X
C4, C10	0.01 uF	2	Kemet	C1206C103K1RACTU
C5, C11	0.1 uF	2	Kemet	C1206C104K1RACTU
C6, C12	1.0 uF	2	AVX	1812C105KAT2A
C7, C13	22 uF	2	Sprague	226K035AT
L1	5.4 nH	1	Coilcraft	0906-5JL
L2	9.85 nH	1	Coilcraft	1606-9JLB
R1	12.1Ohms	1	Vishay	CRC120612R1FKEA

Pin Layout



Note:
The T2G6001528-Q3 will be marked with the “15282” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, and the “MXXX” is the production lot number.

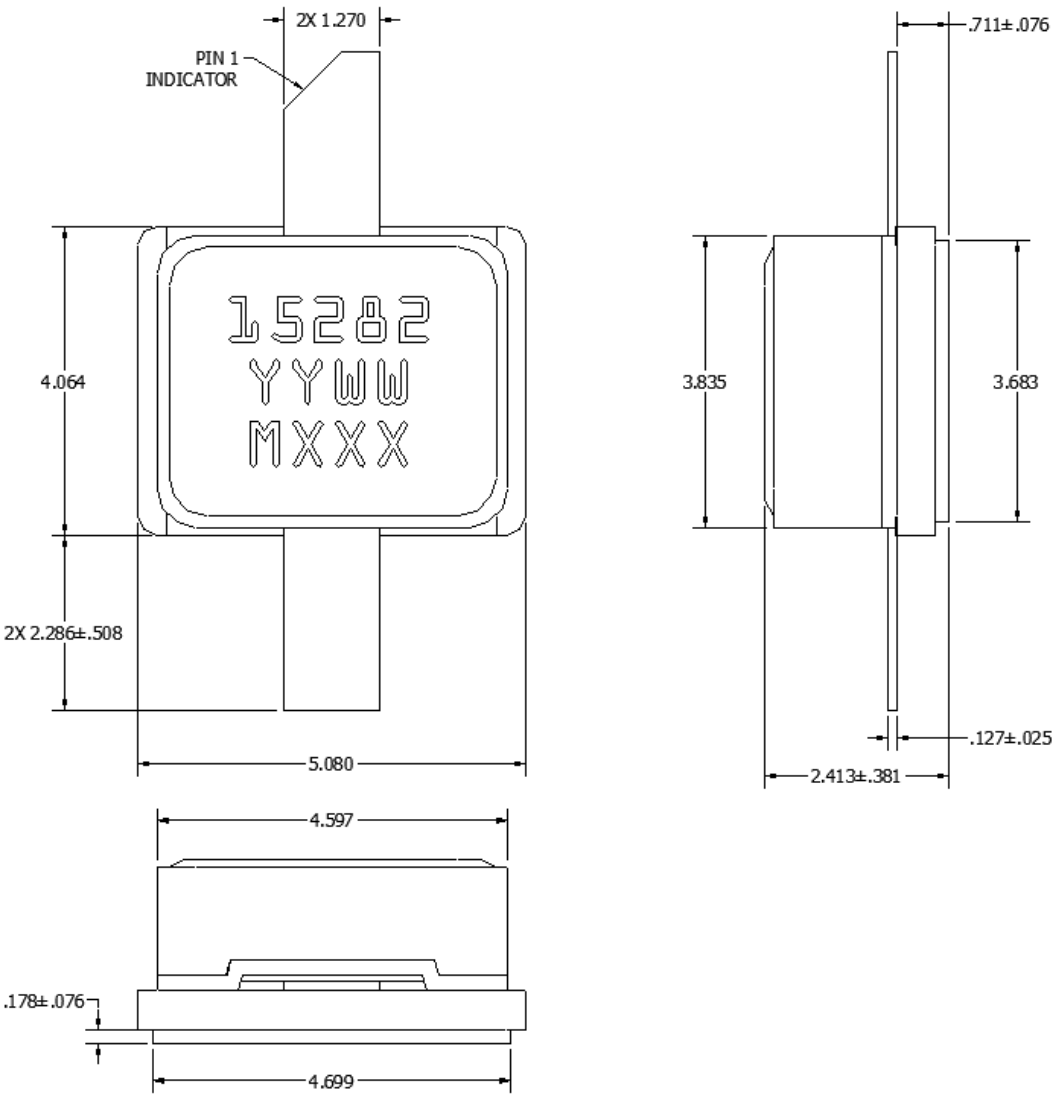
Pin Description

Pin	Symbol	Description
1	V_D / RF OUT	Drain voltage / RF Output matched to 50 ohms; see EVB Layout on page 9 as an example.
2	V_G / RF IN	Gate voltage / RF Input matched to 50 ohms; see EVB Layout on page 9 as an example.
3	Flange	Source connected to ground; see EVB Layout on page 9 as an example.

Notes:
Thermal resistance measured to bottom of package

Mechanical Information

All dimensions are in millimeters. Unless specified otherwise, tolerances are ± 0.127.



Note:
This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 ℃ reflow temperature) and tin-lead (maximum 245℃ reflow temperature) soldering processes.

Product Compliance Information

ESD Sensitivity Ratings

Caution! ESD-Sensitive Device

ESD Rating: Class 1A
Value: Passes ≥ 250 V to < 500 V max.
Test: Human Body Model (HBM)
Standard: JEDEC Standard JESD22-A114

MSL Rating

Level 3 at +260 °C convection reflow
The part is rated Moisture Sensitivity Level 3 at 260°C per JEDEC standard IPC/JEDEC J-STD-020.

ECCN

US Department of Commerce EAR99

Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

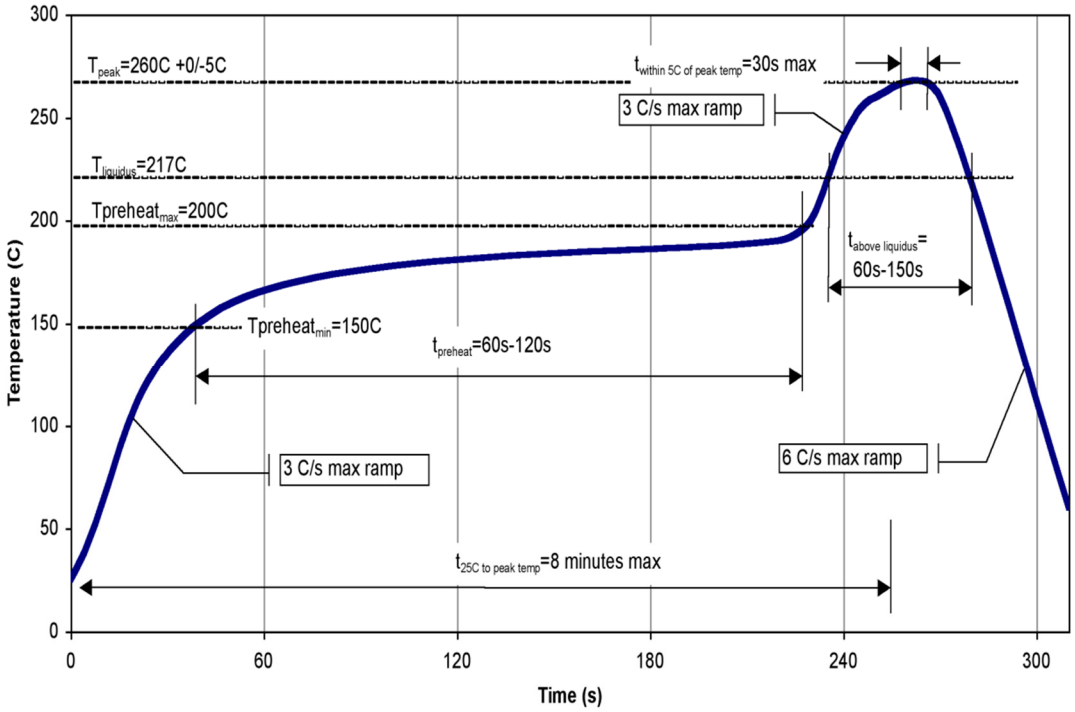
RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

Recommended Soldering Temperature Profile



Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

Web: www.triquint.com **Tel:** +1.972.994.8465
Email: info-sales@triquint.com **Fax:** +1.972.994.8504

For technical questions and application information: **Email:** info-products@triquint.com

Important Notice

The information contained herein is believed to be reliable. TriQuint makes no warranties regarding the information contained herein. TriQuint assumes no responsibility or liability whatsoever for any of the information contained herein. TriQuint assumes no responsibility or liability whatsoever for the use of the information contained herein. The information contained herein is provided "AS IS, WHERE IS" and with all faults, and the entire risk associated with such information is entirely with the user. All information contained herein is subject to change without notice. Customers should obtain and verify the latest relevant information before placing orders for TriQuint products. The information contained herein or any use of such information does not grant, explicitly or implicitly, to any party any patent rights, licenses, or any other intellectual property rights, whether with regard to such information itself or anything described by such information.

TriQuint products are not warranted or authorized for use as critical components in medical, life-saving, or life-sustaining applications, or other applications where a failure would reasonably be expected to cause severe personal injury or death.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for RF Development Tools ***category:***

Click to view products by Qorvo ***manufacturer:***

Other Similar products are found below :

MAAM-011117 MAAP-015036-DIEEV2 EV1HMC1113LP5 EV1HMC6146BLC5A EV1HMC637ALP5 EVAL-ADG919EBZ ADL5363-EVALZ LMV228SDEVAL SKYA21001-EVB SMP1331-085-EVB EV1HMC618ALP3 EVAL01-HMC1041LC4 MAAL-011111-000SMB MAAM-009633-001SMB MASW-000936-001SMB 107712-HMC369LP3 107780-HMC322ALP4 SP000416870 EV1HMC470ALP3 EV1HMC520ALC4 EV1HMC244AG16 MAX2614EVKIT# 124694-HMC742ALP5 SC20ASATEA-8GB-STD MAX2837EVKIT+ MAX2612EVKIT# MAX2692EVKIT# EV1HMC629ALP4E SKY12343-364LF-EVB 108703-HMC452QS16G EV1HMC863ALC4 119197-HMC658LP2 EV1HMC647ALP6 ADL5725-EVALZ 106815-HMC441LM1 EV1HMC1018ALP4 UXN14M9PE MAX2016EVKIT EV1HMC939ALP4 MAX2410EVKIT MAX2204EVKIT+ EV1HMC8073LP3D SIMSA868-DKL SIMSA868C-DKL SKY65806-636EK1 SKY68020-11EK1 SKY67159-396EK1 SKY66181-11-EK1 SKY65804-696EK1 SKY13396-397LF-EVB